

What is claimed is:

1. A method for fabricating a III-V nitride film, comprising the steps of:
preparing a substrate onto a susceptor in a reactor,
heating the substrate to a predetermined temperature,
coating an AlaGabIncN ($a+b+c=1$, $a>0$) film on an interior portion of a reactor which is heated to about 1000°C or over through the heating for the substrate, and
introducing a III raw material gas and a V raw material gas with a carrier gas onto the substrate prepared in the reactor, and thus, fabricating an Al_xGa_yIn_zN ($x+y+z=1$) film by a MOCVD method.
2. A fabricating method as defined in claim 1, wherein the AlaGabIncN film is coated on the susceptor which is heated to about 1000°C or over.
3. A fabricating method as defined in claim 1, wherein the AlaGabIncN ($a+b+c=1$, $a>0$) film includes 50 atomic percentages or over of Al element ($a>0.5$) for all of the III elements. A
4. A fabricating method as defined in claim 3, wherein the AlaGabIncN ($a+b+c=1$, $a>0$) film is composed of an AlN film.
5. A fabricating method as defined in claim 3, wherein the Al_xGa_yIn_zN ($x+y+z=1$) film includes 50 atomic percentages or over of Al element ($a>0.5$) for all of the III elements.
6. A fabricating method as defined in claim 3, wherein the Al_xGa_yIn_zN ($x+y+z=1$) film is composed of an AlN film.
7. An apparatus for fabricating a III-V nitride film by a MOCVD method, comprising:
a reactor in which the MOCVD reaction between a III raw material gas and a V material gas is generated,
a susceptor to hold a substrate thereon installed in the reactor,
a heater to heat the substrate to a predetermined temperature via the susceptor, at least one of the interior wall of the reactor and the susceptor is coated with an AlaGabIncN ($a+b+c=1$, $a>0$) film, which is heated to 1000°C or over.
8. A fabricating apparatus as defined in claim 7, wherein the AlaGabIncN ($a+b+c=1$, $a>0$) film includes 50 atomic percentages or over of Al element ($a>0.5$) for all of the III elements.
9. A fabricating apparatus as defined in claim 8, wherein the AlaGabIncN

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(a+b+c=1, a>0) film is composed of an AlN film.

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